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FDMS8050

March 2015

N-Channel PowerTrench[®] MOSFET 30 V, 200 A, 0.65 m Ω

Features

- Max $r_{DS(on)}$ = 0.65 m Ω at V_{GS} = 10 V, I_D = 55 A
- Max $r_{DS(on)}$ = 0.9 m Ω at V_{GS} = 4.5 V, I_D = 47 A
- \blacksquare Advanced Package and Silicon combination for low $r_{DS(on)}$ and high efficiency
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

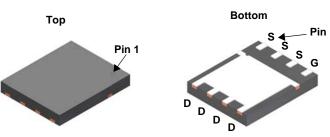


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge and extremely low $r_{DS(on)}$.

Applications

- OringFET
- Synchronous Rectifier





S 2 D D G 4 D D

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parame	ter		Ratings	Units
V_{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage		(Note 4)	±20	V
	Drain Current -Continuous	T _C = 25 °C		200	
I_D	-Continuous	T _A = 25 °C	(Note 1a)	55	Α
	-Pulsed		(Note 5)	400	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	1536	mJ
P _D	Power Dissipation	T _C = 25 °C		156	W
	Power Dissipation	T _A = 25 °C	(Note 1a)	2.7	VV
T _J , T _{STG}	Operating and Storage Junction Temperat	ure Range		-55 to +150	°C

Thermal Characteristics

$R_{ heta JC}$	Thermal Resistance, Junction to Case	0.83	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	45	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8050	FDMS8050	Power 56	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 750 \mu A, V_{GS} = 0 V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 750 μ A, referenced to 25 °C		20		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μА
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 750 \mu A$	1.0	1.8	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 750 μ A, referenced to 25 °C		-6		mV/°C
		V _{GS} = 10 V, I _D = 55 A		0.5	0.65	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 47 \text{ A}$		0.7	0.9	mΩ
,		V _{GS} = 10 V, I _D = 55 A, T _J = 125 °C		0.7	0.9	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 55 A		333		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	16150	22610	pF
C _{oss}	Output Capacitance		4455	6240	pF
C _{rss}	Reverse Transfer Capacitance		220	310	pF
R_g	Gate Resistance		1.0	3.0	Ω

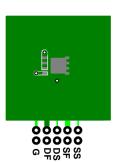
Switching Characteristics

t _{d(on)}	Turn-On Delay Time		29	47	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 55 A,	22	36	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	87	139	ns
t _f	Fall Time		16	28	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V	204	285	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V}$	93	130	nC
Q _{gs}	Gate to Source Charge	I _D = 55 A	41		nC
Q _{gd}	Gate to Drain "Miller" Charge		18		nC

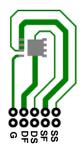
Drain-Source Diode Characteristics

1 Source to Drain Diode, Forward Voltage	Course to Drain Diado, Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2.2 \text{ A}$ (Note 2)	0.6	64	1.2	V
	$V_{GS} = 0 \text{ V}, I_S = 55 \text{ A}$ (Note 2)	0.7	74	1.2	V	
t _{rr}	Reverse Recovery Time	I _E = 55 A, di/dt = 100 A/μs	7	7	124	ns
Q _{rr}	Reverse Recovery Charge	1F - 55 A, αί/αι - 100 A/μs	14	·1	226	nC

^{1.} $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 45 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 115 °C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. E_{AS} of 1536 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 32 A, V_{DD} = 30 V, V_{GS} = 10 V, 100% test at L = 0.3 mH, I_{AS} = 69 A. 4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied. 5. Pulse Id limited by junction temperature, td ≤ 100 μ s. Please refer to SOA curve for more details..

Typical Characteristics T_J = 25 °C unless otherwise noted

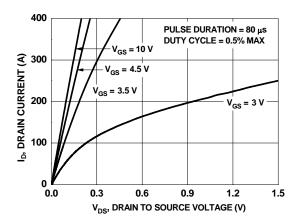


Figure 1. On-Region Characteristics

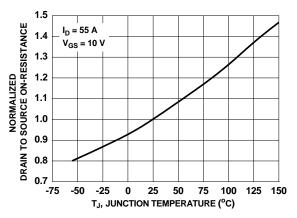


Figure 3. Normalized On-Resistance vs Junction Temperature

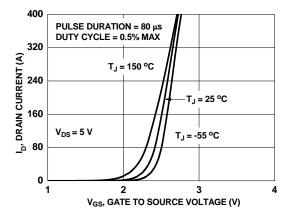


Figure 5. Transfer Characteristics

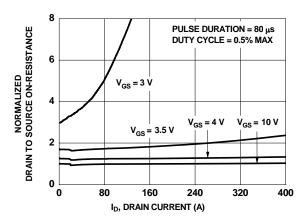


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

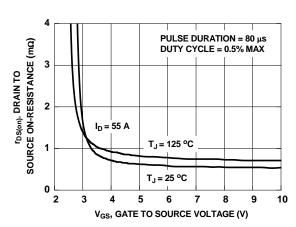


Figure 4. On-Resistance vs Gate to Source Voltage

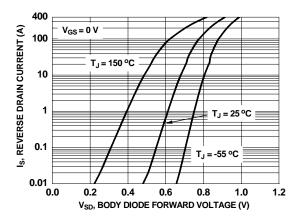


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 $^{\circ}$ C unless otherwise noted

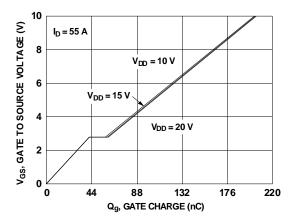


Figure 7. Gate Charge Characteristics

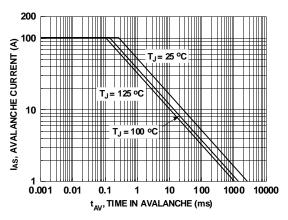


Figure 9. Unclamped Inductive Switching Capability

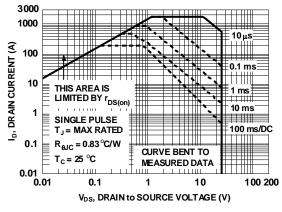


Figure 11. Forward Bias Safe Operating Area

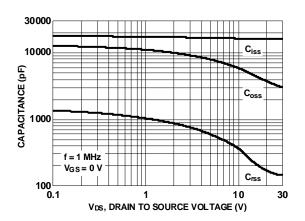


Figure 8. Capacitance vs Drain to Source Voltage

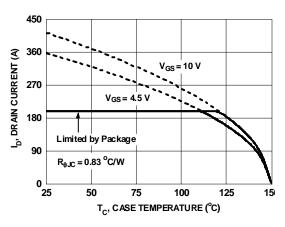


Figure 10. Maximum Continuous Drain Current vs Case Temperature

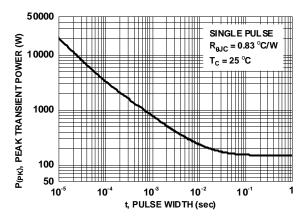


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

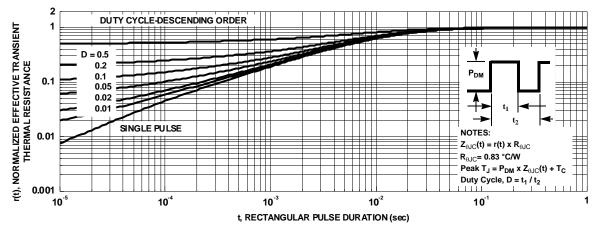
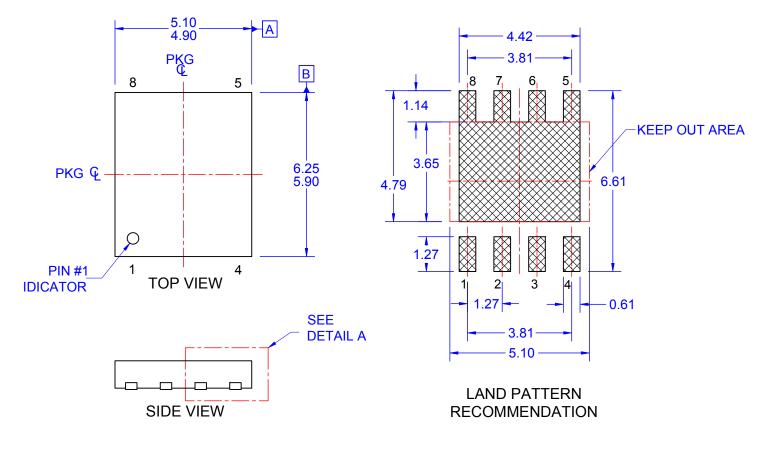
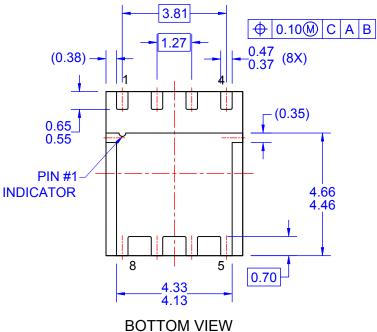
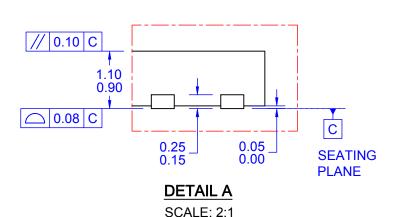


Figure 13. Junction-to-Ambient Transient Thermal Response Curve







NOTES: UNLESS OTHERWISE SPECIFIED

- A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. AA,
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- E) IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.
- F) DRAWING FILE NAME: PQFN08JREV3.



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